Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/644,576	SANCHEZ ET AL.	
Examiner	Art Unit	
Yong S. Chong	1617	

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SEARCHED					
Class	Subclass	Date	Examiner		
514	469	6/15/2005	YSC		
558	422	6/15/2005	YSC		
updated	Search	2/2/06	YIC		
updated	Deach	A124/06	Ysc.		
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INTERFERENCE SEARCHED					
Subclass	Date	Examiner			
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SEARCH NO (INCLUDING SEARC		)
	DATE	EXMR
Inventor (EAST, PALM)	6/15/2005	YSC
Text (EAST, STN)	6/15/2005	YSC
Updated Search	2/2/06	Ysc
Updated Search	8/28/00	Yse.
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